

Search Notes

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10/667,872

Examiner

April Y. Shan

Applicant(s)/Patent under
Reexamination

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Art Unit

2135

SEARCHED

Class	Subclass	Date	Examiner
726	26	1/6/2008	A.S.
	28	1/6/2008	A.S.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (see EAST)	1/6/2008	A.S.